

**Supplementary Material**

**Crystal structure studies towards the synthesis and  
applications of NHC-metal complexes derived from  
[2.2]paracyclophane**

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## Experimental Section

### Materials and methods.

All chemicals were commercially purchased and used as received.

Solvents were reagent grade and purified by standard techniques.  $^1\text{H}$  and  $^{13}\text{C}$  spectra were recorded on Bruker AVANCE 300 at 298K. Chemical shifts were reported as  $\delta$  values in ppm and referenced to using tetramethylsilane as an internal. Data are reported as (s = singlet, d = doublet, dd = doublet of doublet, ddd = doublet of doublet of doublet, t = triplet, dt = doublet of triplet, td = triplet of doublet, q = quartet, qd = quartet of doublet, m = multiplet, brs = broad singlet). Coupling constants were reported in Hertz (Hz). All high resolution mass spectra were obtained on an Agilent Technologies 6510 Q-ToF LC/MS. All reactions were monitored by TLC with silica gel-coated plates and visualized with a UV light at 254 nm. Melting points were recorded on a melting point apparatus and were uncorrected. Optical rotations were measured on a automatic polarimeter WZZ-2B equipped with a sodium lamp ( $\lambda = 589$  nm) and reported as follows:  $[\alpha]_{\text{D}}^{\text{T}}$  (c = g/100 mL, solvent). Enantiomeric excess was determined using HPLC on Chiralpak IA chiral column.

### X-ray Crystallography.

The crystallographic data of **1-7** were collected on a Bruker Smart APEX CCD area-detector diffractometer with Mo-K $\alpha$  radiation ( $\lambda = 0.71073$  Å). The crystal data were solved by direct methods and refined by a full-matrix least-square method on  $F^2$  using the *SHELXL-97* crystallographic software package.<sup>S1</sup> Full crystallographic data for **1-7** have been deposited with the **CCDC 1023337, CCDC 753625, CCDC**

1015372, CCDC 821397, CCDC 1017723, CCDC 1017741 and CCDC 903887.

These data can be obtained free of charge from The Cambridge Crystallographic Data

Centre via [www.ccdc.cam.ac.uk/data\\_request/cif](http://www.ccdc.cam.ac.uk/data_request/cif).<sup>S2</sup>

## References

S1 (a) G. M. Sheldrick, *SHELXL97, Program for Crystal Structure Refinement*; University of Göttingen: Göttingen, Germany, 1997; (b) G. M. Sheldrick, *SHELXS97, Program for Crystal Structure Solution*; University of Göttingen: Göttingen, Germany, 1997.

S2 The checkcif program available at:

<http://journals.iucr.org/services/cif/checkcif.html>.

## Spectra copies





